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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

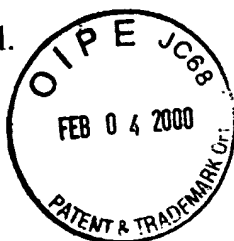
#6

Applicant : S. WAKASHIRO et al.

Serial No : 09/407,855

Filed : September 29, 1999

For : TARGET FOR PHOTOGRAMMETRIC ANALYTICAL MEASUREMENT  
SYSTEM



Group Art Unit: 2721

Examiner: Unknown

STATEMENT OF RELEVANCE

Commissioner of Patents and Trademarks  
Washington, DC 20231

Sir:


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Supplemental to the Information Disclosure Statement of December 29, 1999, in which it was stated that an English translation of JP 10-170263 would be filed shortly, Applicants note that they have elected to submit this Statement of Relevance instead of a full translation. To that end, Applicants note that JP 10-170263 discloses a target having three standard points, used for photogrammetric analytic measurement. Applicants' originally filed specification discloses a detailed discussion of the same beginning at page 2, line 22.

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Should there be any questions, the Examiner is invited to contact the undersigned attorney at the number listed below.

Respectfully submitted,  
S. WAKASHIRO et al.

  
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36,715

February 3, 2000  
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